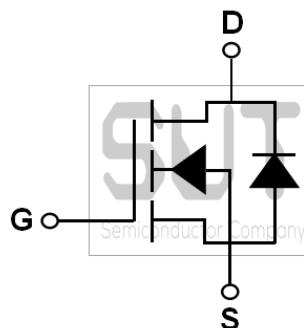
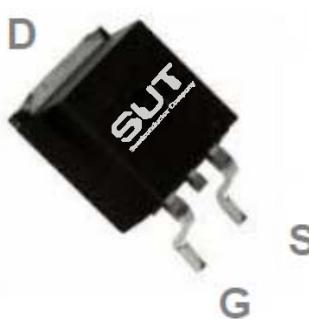


N-Channel 80-V_(D-S) MOSFET

PRODUCT SUMMARY		
B _{VDS} (V)	R _{DS(on)} (mΩ)(MAX)	I _D (A)
80	6.0@V _{GS} =10V	120

TO263 Pin Configuration



ABSOLUTE MAXIMUM RATINGS(T_C=25°C UNLESS OTHERWISE NOTED)

Parameter	Symbol	Rating	Units
Drain-Source Voltage	V _{DS}	80	V
Gate-Source Voltage	V _{GS}	±20	V
Drain Current-Continuous (T _C =25°C)	I _D	120	A
Drain Current-Continuous (T _C =100°C)		75	A
Drain Current-Pulsed ¹	I _{DM}	480	A
Single Pulse Avalanche Energy ²	EAS	230	mJ
Single Pulse Avalanche Current ²	I _{AS}	68	A
Power Dissipation (T _C =25°C)	P _D	183	W
Power Dissipation-Derate above 25°C		1.47	W/°C
Storage Temperature Range	T _{STG}	-50 to 150	°C
Operating Junction Temperature Range	T _J	-50 to 150	°C

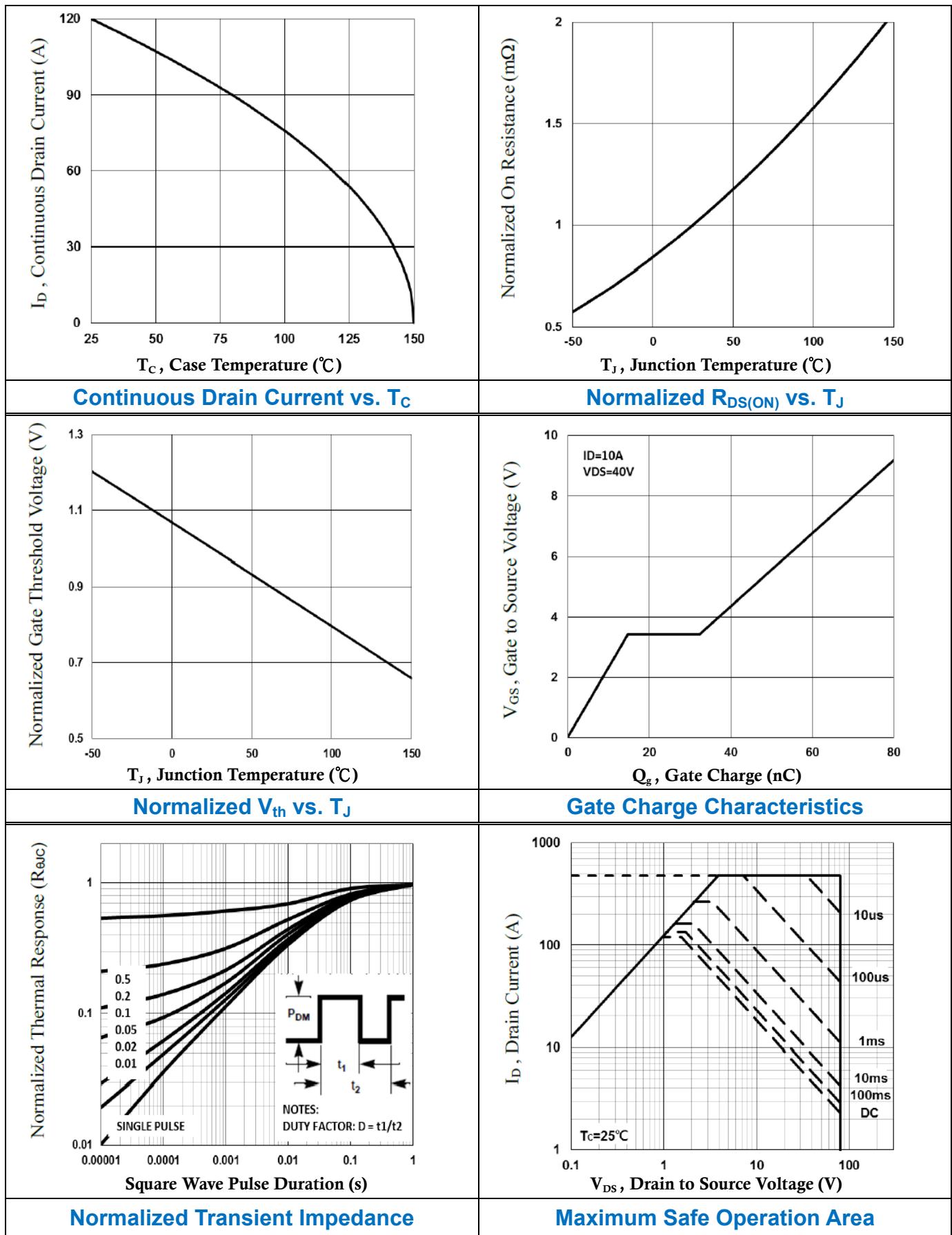
THERMAL CHARACTERISTICS

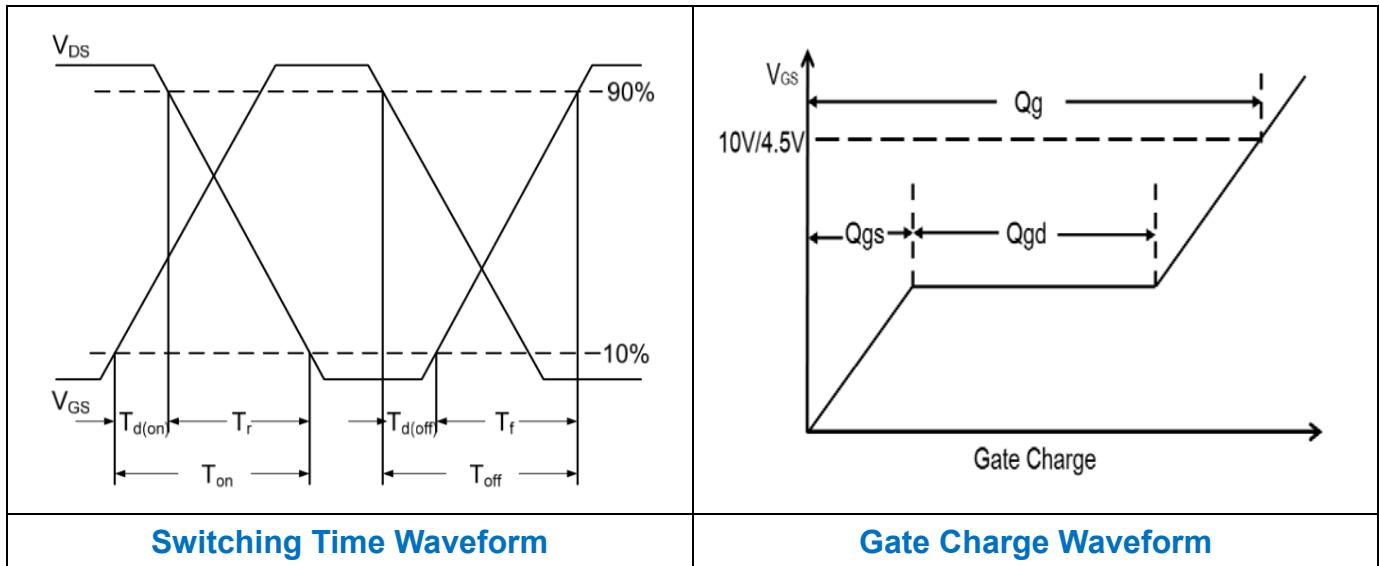
Parameter	Symbol	Typ.	Max.	Unit
Thermal Resistance Junction to ambient	R _{θJA}	---	62	°C/W
Thermal Resistance Junction to Case	R _{θJC}	---	0.68	°C/W

ELECTRICAL CHARACTERISTICS ($T_J=25^\circ\text{C}$ UNLESS OTHERWISE NOTED)						
Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250\mu\text{A}$	80	---	---	V
Drain-Source Leakage Current	I_{DSS}	$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=80\text{V}, T_J=25^\circ\text{C}$	---	---	1	μA
		$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=64\text{V}, T_J=125^\circ\text{C}$	---	---	10	μA
Gate-Source Leakage Current	I_{GSS}	$V_{\text{GS}}=\pm 25\text{V}, V_{\text{DS}}=0\text{V}$	---	---	± 100	nA
On Characteristics						
Static Drain-Source On-Resistance	$R_{\text{DS}(\text{ON})}$	$V_{\text{GS}}=10\text{V}, I_{\text{D}}=15\text{A}$	---	5.0	6.0	$\text{m}\Omega$
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{GS}}=V_{\text{DS}}, I_{\text{D}}=250\mu\text{A}$	2.0	3.0	4.0	V
Forward Transconductance	g_{fs}	$V_{\text{DS}}=10\text{V}, I_{\text{D}}=3\text{A}$	---	18	---	S
Dynamic and Switching Characteristics						
Total Gate Charge ^{3, 4}	Q_g	$V_{\text{GS}}=10\text{V}, V_{\text{DS}}=64\text{V}, I_{\text{D}}=10\text{A}$	---	88	---	nC
Gate-Source Charge ^{3, 4}	Q_{gs}		---	10	---	
Gate-Drain Charge ^{3, 4}	Q_{gd}		---	24	---	
Turn-On Delay Time ^{3, 4}	$T_{\text{d}(\text{on})}$	$V_{\text{GS}}=10\text{V}, V_{\text{DD}}=40\text{V}, R_{\text{G}}=6\Omega, I_{\text{D}}=10\text{A}$	---	20	---	ns
Rise Time ^{3, 4}	T_r		---	13	---	
Turn-Off Delay Time ^{3, 4}	$T_{\text{d}(\text{off})}$		---	36	---	
Fall Time ^{3, 4}	T_f		---	18	---	
Input Capacitance	C_{iss}	$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=25\text{V}, F=1\text{MHz}$	---	5160	---	pF
Output Capacitance	C_{oss}		---	646	---	
Reverse Transfer Capacitance	C_{rss}		---	110	---	
Gate resistance	R_g	$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=0\text{V}, F=1\text{MHz}$	---	1.6	3.2	Ω
Drain-Source Diode Characteristics and Maximum Ratings						
Continuous Source Current	I_s	$V_G=V_D=0\text{V}$, Force Current	---	---	120	A
Pulsed Source Current	I_{SM}		---	---	240	A
Diode Forward Voltage	V_{SD}	$V_{\text{GS}}=0\text{V}, I_s=1\text{A}, T_J=25^\circ\text{C}$	---	---	1.0	V
Reverse Recovery Time	t_{rr}	$V_{\text{GS}}=0\text{V}, I_s=20\text{A}, dI/dt=100\text{A}/\mu\text{s}, T_J=25^\circ\text{C}$	---	28	---	ns
Reverse Recovery Charge	Q_{rr}		---	20	---	nC

Note :

- Repetitive Rating : Pulsed width limited by maximum junction temperature.
- $V_{\text{GS}}=10\text{V}, V_{\text{DD}}=50\text{V}, L=0.1\text{mH}, I_{\text{AS}}=68\text{A}, R_{\text{G}}=25\Omega$, Starting $T_J=25^\circ\text{C}$.
- The data tested by pulsed, pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$.
- Essentially independent of operating temperature.





TO263 PACKAGE INFORMATION

